

Notice of References Cited	Application/Control No. 10/760,454	Applicant(s)/Patent Under Reexamination LEE, SUNG-WOOK	
	Examiner Scott R. Wilson	Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,714,840	02-1998	Tanabe et al.	313/581
*	C	US-2003/0102477	06-2003	Lee, Yoon-Kwan	257/72
*	D	US-5,948,537	09-1999	Onoda et al.	428/426
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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